



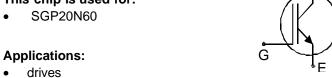
# SIGC18T60SN

### IGBT Chip in NPT-technology

### **FEATURES:**

- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- · easy paralleling

### This chip is used for:



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC18T60SN	600V	20A	4.3 x 4.3 mm <sup>2</sup>	sawn on foil	Q67041-S2856-	
					A001	

### **MECHANICAL PARAMETER:**

MECHANICAL PARAMETER:					
Raster size	4.3 × 4.3				
Area total / active	18.49 / 14.3				
Emitter pad size	2.48 x 2.98				
Gate pad size	0.70 x 1.08				
Thickness	100	μm			
Wafer size	125	mm			
Flat position	270	deg			
Max.possible chips per wafer	537				
Passivation frontside	Photoimide				
Emitter metalization	3200 nm Al Si 1%				
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bo				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	tbd				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month				



## SIGC18T60SN

### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	20	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	40	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

## $\textbf{STATIC CHARACTERISTICS} \text{ (tested on chip), } \textit{T}_{j}\text{=}25~^{\circ}\text{C, unless otherwise specified:}$

Parameter	Symbol	Conditions	Value			Unit
T diameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ =500 $\mu$ A	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =20A	1.6	1.9	2.5	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C$ =500 $\mu$ A , $V_{GE}$ = $V_{CE}$	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V , V <sub>GE</sub> =0V			70	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =30V			120	nA

### **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
rarameter			min.	typ.	max.	Oilit
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	1100	1320	pF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	107	128	
Reverse transfer capacitance	C <sub>rss</sub>	f=1MHz	-	63	75	

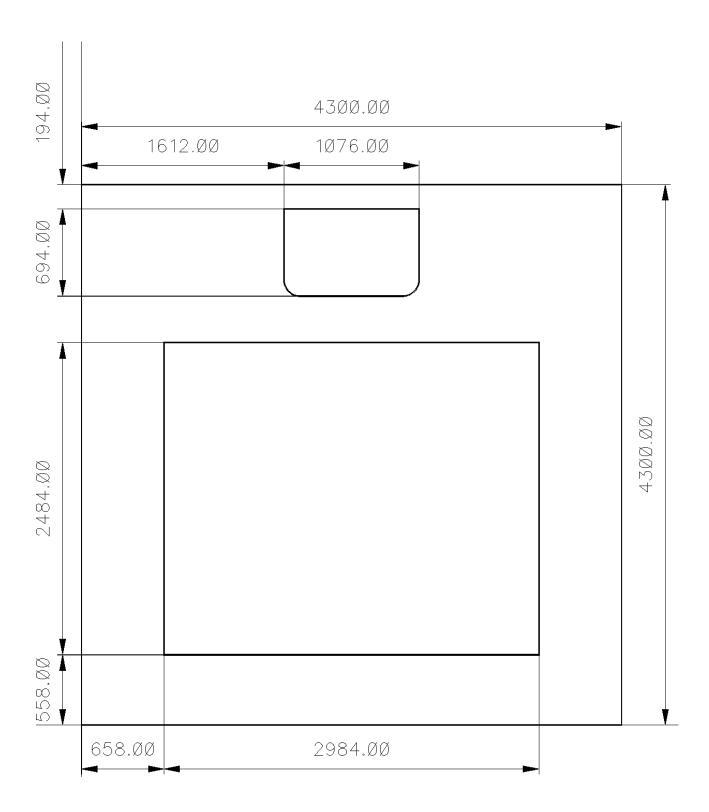
### **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	$T_j=25 ^{\circ}\text{C}$ $V_{\text{CC}}=400\text{V}$ , $I_{\text{C}}=20\text{A}$	-	24	29	ns
Rise time	t <sub>r</sub>	$I_{\rm C}$ =20A	-	38	46	
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}}$ =+15/0V, $R_{\text{G}}$ =16 $\Omega$	-	225	270	
Fall time	$t_{f}$	7.6- 1.022	-	54	65	



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### **CHIP DRAWING:**





### **Preliminary**

### SIGC18T60SN

#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet SGP20N60 Package :TO220

### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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